

#3 IDS  
5-2-01  
Ratku

12/13/00

# Notice of References Cited

Application No.

08/912,979  
23/736724

Applicant(s)

Yamazaki et al

Examiner

Edward Wojciechowicz

Group Art Unit

2815

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	DOCUMENT NO.	DATE	NAME	CLASS	SUBCLASS
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Carl E. Gork # 7/26/2001

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09/736,724

Applicant(s)/Patent Under  
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YAMAZAKI ET AL.

Examiner

Paul E Brock II

Art Unit

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	K	US-			
	L	US-			
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